

Definition 6

An error relying on rejection of a true null hypothesis  $H_0$  is called the Type I error (error of the first kind).

An error relying on acceptance of a false null hypothesis  $H_0$  is called the Type II error (error of the second kind).

Illustration

		Decision	
		$H_0$	$H_1$
Truth	$H_0$	X	Type I error
	$H_1$	Type II error	X

Definition 7

Let  $C$  be a critical region. The measurable function of the form  $\mathbb{I}_C(x)$  is called a (non-randomized) test of the hypothesis  $H_0$  against the alternative  $H_1$  and is denoted by  $\varphi(x)$  or  $\varphi$ , for short.

Definition 8

A number  $\alpha \in (0, 1)$  is called the significance level.

Remark 2

Usually,  $\alpha = 0.01, \alpha = 0.05, \alpha = 0.1$ .

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Let  $\alpha \in (0, 1)$ . It is <sup>said</sup> (called) that the test  $\varphi$  is at the significance level  $\alpha$ , if (and only if)

$$\sup_{\theta \in \mathcal{H}_0} \mathbb{E}_{\theta}[\varphi(X)] = \sup_{\theta \in \mathcal{H}_0} \mathbb{P}_{\theta}(X \in C) \leq \alpha.$$

If  $\sup_{\theta \in \mathcal{H}_0} \mathbb{E}_{\theta}[\varphi(X)] = \alpha,$

it is said that the test  $\varphi$  has the size  $\alpha$ .

### Definition 10

The function  $\gamma: \mathcal{H} \rightarrow [0, 1]$  defined as follows:

$$\gamma(\theta) = \mathbb{P}_{\theta}(X \in C) - \mathbb{E}_{\theta}[\varphi(X)] \text{ for } \theta \in \mathcal{H}$$

is called the power function of the test  $\varphi$ .

The number  $\gamma(\theta)$  for  $\theta \in \mathcal{H}_1$  is called the power of the test  $\varphi$  under the alternative  $\theta$ .

### Remark 3

Statistical tests are constructed in such a manner in order to minimize the probability of <sup>making</sup> the Type II error under give fixed probability of making the Type I error equals  $\alpha$ .

## 2. Neyman - Pearson Lemma

### Definition 1

It is said that the test  $\varphi_0$  is ~~the~~ uniformly most powerful at the significance level  $\alpha$ , if for any another test  $\varphi$  at the same significance level

$$E_{\theta}[\varphi(X)] \leq E_{\theta}[\varphi_0(X)] \quad \text{for any } \theta \in \Theta_1.$$

### Theorem 1 (Neyman Pearson Lemma)

Let  $X_1, \dots, X_n$  be a sample with  $f(x, \theta)$ .

Consider the testing problem

$$H_0: \theta \in \Theta_0,$$

$$H_1: \theta = \theta_1,$$

and the  $\alpha$ -size  $\varphi_0$  test of the form

$$\varphi_0(x) = \begin{cases} 1, & \text{if } \prod_{i=1}^n f(x_i, \theta_0) < k \prod_{i=1}^n f(x_i, \theta_1), \\ \gamma, & \text{if } \prod_{i=1}^n f(x_i, \theta_0) = \prod_{i=1}^n f(x_i, \theta_1), \\ 0, & \text{if } \prod_{i=1}^n f(x_i, \theta_0) > \prod_{i=1}^n f(x_i, \theta_1), \end{cases}$$

where the constants  $k$  and  $\gamma$  are satisfying

the condition  $E_{\theta_0}[\varphi(X)] = \alpha$ . Then,  $\varphi_0$  is the UMP test in the problem  $(H_0, H_1)$ .

### Corollary 1

Under the conditions of Theorem 1,  $\gamma \varphi_0(\theta_1) \geq \alpha$ .

Example 1

$X_1, \dots, X_n$  i.i.d  $X_i \sim f(x_i, \theta) = \frac{1}{\sqrt{2\pi}} \exp\left\{-\frac{(x_i - \theta)^2}{2}\right\}, x_i \in \mathbb{R}.$

We verify

$$H_0: \theta = 0,$$

$$H_1: \theta = 1.$$

We have

$$\frac{L(1, x)}{L(0, x)} = \frac{\left(\frac{1}{\sqrt{2\pi}}\right)^n \exp\left(-\frac{\sum_{i=1}^n (x_i - 1)^2}{2}\right)}{\left(\frac{1}{\sqrt{2\pi}}\right)^n \exp\left(-\frac{\sum_{i=1}^n x_i^2}{2}\right)} = \exp\left(\sum_{i=1}^n x_i - \frac{n}{2}\right) > k_1.$$

Thus

$$\sum_{i=1}^n x_i - \frac{n}{2} > \log k_1 \Leftrightarrow \sum_{i=1}^n x_i > \log k_1 + \frac{n}{2} = k.$$

Thereby, the critical region of the UMP test has the form

$$C = \{x: \sum_{i=1}^n x_i > k\},$$

while the constant  $k$  satisfies the condition  $P_0(X \in C) = \alpha$ .

So,  $P_0\left(\sum_{i=1}^n X_i > k\right) = \alpha$ . Since, under  $H_0$ ,  $\sum_{i=1}^n X_i \sim N(0, n)$ ,

we have 
$$P_0\left(\sum_{i=1}^n X_i > k\right) = P_0\left(\frac{\sum_{i=1}^n X_i}{\sqrt{n}} > \frac{k}{\sqrt{n}}\right) =$$

$$1 - \Phi\left(\frac{k}{\sqrt{n}}\right) = \alpha. \text{ As a result, } \frac{k}{\sqrt{n}} = \Phi^{-1}(1 - \alpha) \text{ and } k = \sqrt{n} \Phi^{-1}(1 - \alpha).$$

On the other hand, under  $H_1$ ,  $\sum_{i=1}^n X_i \sim N(n, n)$ , and

$$\gamma(\theta_1) = \gamma(1) = P_1\left(\sum_{i=1}^n X_i > k\right) = P_1\left(\frac{\sum_{i=1}^n X_i - n}{\sqrt{n}} > \frac{k - n}{\sqrt{n}}\right) =$$

$$1 - \Phi\left(\frac{k - n}{\sqrt{n}}\right) = 1 - \Phi\left(\Phi^{-1}(1 - \alpha) - \sqrt{n}\right).$$



### 3. The UMP for 'composite hyp alternative

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#### Example 1

$X_1, \dots, X_n$  i.i.d,  $X_1 \sim N(0, \theta), \theta > 0$ .

We test

$$H_0: \theta = \theta_0,$$

$$A: \theta > \theta_0.$$

We find the UMP  $\alpha$ -level test.

We have

$$L(\theta) = L(\theta, \underline{x}) = \left(\frac{1}{2\pi\theta}\right)^{n/2} \exp\left\{-\frac{1}{2\theta} \sum_{i=1}^n x_i^2\right\}.$$

Let  $\theta_1 > \theta_0$ , and  $k_1 > 0$ . Then,

$$\frac{L(\theta_1)}{L(\theta_0)} \geq k_1 \Leftrightarrow \left(\frac{\theta_0}{\theta_1}\right)^n \exp\left\{-\frac{\theta_1 - \theta_0}{2\theta_0\theta_1} \sum_{i=1}^n x_i^2\right\} \geq k_1 \Leftrightarrow$$

$$\sum_{i=1}^n x_i^2 \geq k.$$

The critical region has a form

$$C = \{(x_1, \dots, x_n) : \sum_{i=1}^n x_i^2 \geq k\}$$

and corresponds to the UMP test in the problem

$$H_0: \theta = \theta_0,$$

$$H_1: \theta = \theta_1,$$

where the constant  $k$  satisfies the condition  $P_0\left(\sum_{i=1}^n X_i^2 \geq k\right) = \alpha$ .

Since  $\sum_{i=1}^n X_i^2 / \theta \sim \chi_n^2$ , we have

$$P_0\left(\sum_{i=1}^n X_i^2 \geq k\right) = P_0\left(\sum_{i=1}^n X_i^2 / \theta_0 \geq \frac{k}{\theta_0}\right) = 1 - F_{\chi_n^2}\left(\frac{k}{\theta_0}\right).$$

As a result,  $\frac{k}{\theta_0} = q_{\chi_n^2}(0.95)$ .